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heet	1	of	1	Attorney Docket Number	H6810.0011/P011	Ţ.	

U.S. PATENT DOCUMENTS						
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K.N.	Α	"Off Current Dependence on Farbrication Process of a Back-Channel-Etching-Type a-Si TFT" by Washizuka et al. (IDW 1997 pp. 207-210)			
K.N.	В	Nikkei Microdevices (June, 2000 p.175)			

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